.*	Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/539,223	LEE ET AL.	
Examiner	Art Unit	
Sara W. Crane	2811	

SEARCHED					
Class	Subclass	Date	Examiner		
757	40	6/06	Swc		
257	40	12/06	SWC		
	762	,			
	759				
251	752	12106	SwC		
	753				

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
		-				
	1					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST see printout	12/06	SWC	
see printont			
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